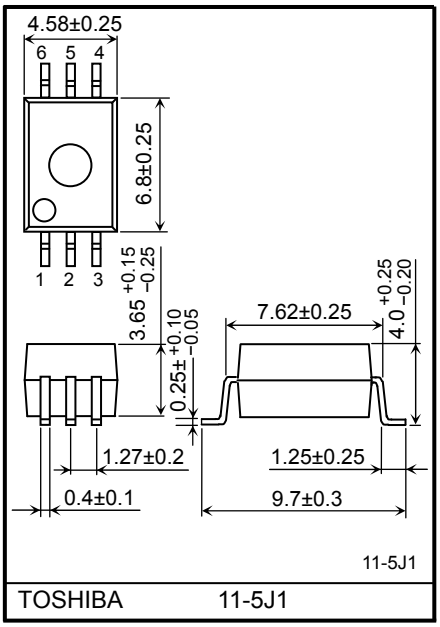
TOSHIBA PHOTOCOUPLER GaAℓAs IRED & PHOTO-IC

TLP718

Isolated Bus Drivers
High Speed Line Receivers
Microprocessor System Interfaces

Unit in mm



Weight:0.26 g (typ.)

The Toshiba TLP718 consists of a GaAℓAs light-emitting diode and an integrated high-gain, high-speed photodetector. This unit is a 6-pin SDIP. The TLP718 is 50% smaller than the 8-PIN DIP and meets the reinforced insulation class requirements of international safety standards. Therefore the mounting area can be reduced in equipment requiring safety standard certification.

The detector has a totem pole output stage to provide both source and sink driving. The detector IC has an internal shield that provides a guaranteed common-mode transient immunity of 10 kV / μs.

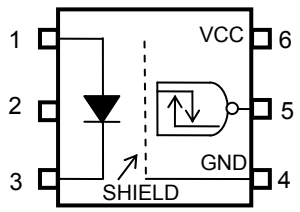
The TLP718 is inverter logic type. For buffer logic type, the TLP715 is in line-up.

- Inverter logic type (totem pole output)
- Guaranteed performance over temperature : −40 to 100°C
- Power supply voltage : 4.5 to 20 V
- Input current: I_{FHL} = 3mA (Max.)
- Switching time (t_{pHL} / t_{pLH}) : 250 ns (Max.)
- Common-mode transient immunity : ±10 kV/μs (Min)
- Isolation voltage : 5000 Vrms (Min)
- UL recognized
  UL1577, File No.E67349
- c-UL recognized
  CSA Component Acceptance Service No. 5A, File No.E67349
- Option (D4)
  TÜV recognized / VDE under application : DIN EN60747-5-2

  Maximum Operating Insulation Voltage : 890V_{PK}
  Highest Permissible Over Voltage : 8000V_{PK}
  (Note) : When a EN60747-5-2 approved type is needed, Please designate "Option(D4)"
- Construction Mechanical Rating

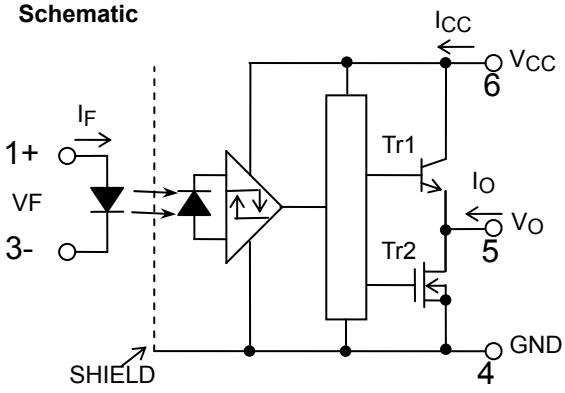
	7.62 mm pitch standard type	10.16 mm pitch TLPXXXF type
Creepage Distance	7.0 mm (Min)	8.0 mm (Min)
Clearance	7.0 mm (Min)	8.0 mm (Min)
Insulation Thickness	0.4 mm (Min)	0.4 mm (Min)

Pin Configuration (Top View)



1:ANODE
2:N.C.
3:CATHODE
4:GND
5:Vo (Output)
6:Vcc

Schematic



0.1 μF bypass capacitor must be connected between pins 6 and 4. (Note 5)

Truth Table

Input	LED	Tr1	Tr2	Output
H	ON	OFF	ON	L
L	OFF	ON	OFF	H

Absolute Maximum Ratings (Ta = 25°C)

CHARACTERISTIC		SYMBOL	RATING	UNIT
LED	Forward Current (Ta ≤ 83°C)	I_F	20	mA
	Forward Current Derating (Ta ≥ 83°C)	$\Delta I_F/\Delta Ta$	−0.48	mA/°C
	Peak Transient Forward Current (Note 1)	I_{FPT}	1	A
	Reverse Voltage	V_R	5	V
	Junction Temperature	Tj	125	°C
DETECTOR	Output Current 1 (Ta ≤ 25°C)	I_{O1}	25 / −15	mA
	Output Current 2 (Ta ≤ 100°C)	I_{O2}	13 / −13	mA
	Output Voltage	V_O	−0.5 to 20	V
	Supply Voltage	V_{CC}	−0.5 to 20	V
	Junction Temperature	Tj	125	°C
Operating Temperature Range		Topr	−40 to 100	°C
Storage Temperature Range		Tstg	−55 to 125	°C
Lead Solder Temperature (10 s)		Tsol	260	°C
Isolation Voltage (AC,1 min., R.H. ≤ 60%, Ta = 25°C) (Note 2)		BVs	5000	Vrms

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.
Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook (“Handling Precautions”/“Derating Concept and Methods”) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: Pulse width PW ≤ 1us, 300pps.

Note 2: Device Considered a two terminal device : pins 1,2 and 3 shorted together and pins 4,5 and 6 shorted together.

Recommended Operating Conditions

CHARACTERISTIC	SYMBOL	MIN	TYP.	MAX	UNIT
Input Current, ON	$I_{F\ (ON)}$	4.5	−	10	mA
Input Voltage, OFF	$V_{F\ (OFF)}$	0	−	0.8	V
Supply Voltage*	V_{CC}	4.5	−	20	V
Operating Temperature	T_{opr}	-40	−	100	°C

* This item denotes operating ranges, not meaning of recommended operating conditions.

Note: Recommended operating conditions are given as a design guideline to obtain expected performance of the device. Additionally, each item is an independent guideline respectively. In developing designs using this product, please confirm specified characteristics shown in this document.

Electrical Characteristics
(Unless otherwise specified, Ta =−40 to 100°C, V_{CC} = 4.5 to 20 V.)

CHARACTERISTIC	SYMBOL	TEST CIRCUIT	CONDITION		MIN	TYP. *	MAX	UNIT
Input forward voltage	V_F	—	I_F = 5 mA , Ta = 25°C		1.4	1.6	1.7	V
Temperature coefficient of forward voltage	$\Delta V_F/\Delta Ta$	—	I_F = 5 mA		—	−2.0	—	mV/°C
Input reverse current	I_R	—	V_R = 5 V , Ta = 25°C		—	—	10	μA
Input capacitance	C_T	—	V = 0 V, f = 1 MHz, Ta = 25°C		—	45	—	pF
Logic LOW output voltage	V_{OL}	1	I_{OL} = 3.5 mA , I_F = 5 mA		—	0.2	0.6	V
Logic HIGH output voltage	V_{OH} (Note3)	2	I_{OH} = −2.6 mA, VF = 0.8 V	V_{CC} = 4.5 V	2.7	3.5	—	V
				V_{CC} = 20 V	17.4	19	—	
Logic LOW supply current	I_{CCL}	3	I_F = 5 mA		—	—	3.0	mA
Logic HIGH supply current	I_{CCH}	4	V_F=0V		—	—	3.0	mA
Logic LOW short circuit output current	I_{OSL}	5	I_F = 5 mA	V_{CC} = V_O = 5.5 V	15	80	—	mA
				V_{CC} = V_O = 20 V	20	90	—	
Logic HIGH short circuit output current (Note4)	I_{OSH}	6	V_F = 0 V, V_O = GND	V_{CC} = 5.5 V	−5	-15	—	mA
				V_{CC} = 20 V	−10	−20	—	
Input current logic LOW output (Note4)	I_{FHL}	—	I_O = 3.5 mA, V_O < 0.6 V		—	0.4	3	mA
Input voltage logic HIGH output	V_{FLH}	—	I_O = −2.6 mA, V_O > 2.4V		0.8	—	—	V
Input current hysteresis	I_{HYS}	—	V_{CC} = 5 V		—	0.05	—	mA

* All typical values are at Ta=25°C, V_{CC}=5 V unless otherwise specified

Note 3: V_{OH}=V_{CC} –V_O [V]

Note 4: Duration of output short circuit time should not exceed 10 ms.

Note 5: A ceramic capacitor (0.1 μA) should be connected from pin 6 to pin 4 to stabilize the operation of the high gain linear amplifier. Failure to provide the bypassing may impair the switching property. The total lead length between capacitor and coupler should not exceed 1 cm.

Isolation Characteristics (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN	TYP.	MAX	UNIT
Capacitance input to output	C_S	V = 0V, f = 1 MHz (Note 2)	—	1.0	—	pF
Isolation resistance	R_S	R.H. ≤ 60%, V_S = 500 V (Note 2)	1×10^{12}	10^{14}	—	Ω
Isolation voltage	BV_S	AC, 1 minute	5000	—	—	V_{rms}
		AC, 1 second, in oil	—	10000	—	
		DC, 1 minute, in oil	—	10000	—	Vdc

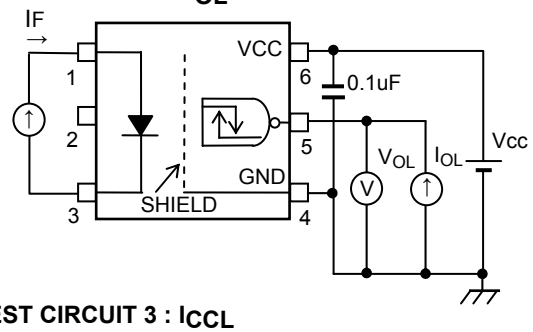
Switching Characteristics

(Unless otherwise specified, Ta = −40 to 100°C, V_{CC} = 4.5 to 20 V)

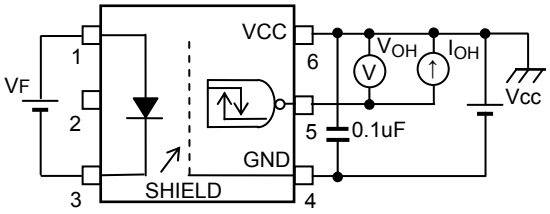
CHARACTERISTIC	SYMBOL	TEST CIRCUIT	CONDITION	MIN	TYP. *	MAX	UNIT
Propagation delay time to logic HIGH output	t_{pLH}	7,8	I_F = 3→ 0 mA	30	120	250	ns
Propagation delay time to logic LOW output	t_{pHL}		I_F = 0 → 3 mA	30	120	250	ns
Switching time dispersion between ON and OFF	$\lvert t_{pHL} - t_{pLH} \rvert$		—	—	—	220	ns
Rise Time (10 – 90 %)	tr		I_F = 3 → 0 mA, V_{CC} = 5 V	—	30	—	ns
Fall Time (90 – 10 %)	tf		I_F = 0 → 3 mA, V_{CC} = 5 V	—	30	—	ns
Common-mode transient Immunity at HIGH level output	CM_H	9	V_{CM} = 1000 Vp-p, I_F = 0 mA, V_{CC} = 20 V, Ta = 25°C	10000	—	—	V/us
Common-mode transient Immunity at LOW level output	CM_L		V_{CM} = 1000 Vp-p, I_F = 5 mA, V_{CC} = 20 V, Ta = 25°C	−10000	—	—	V/us

*All typical values are at Ta = 25°C.

TEST CIRCUIT 1 : V_{OL}

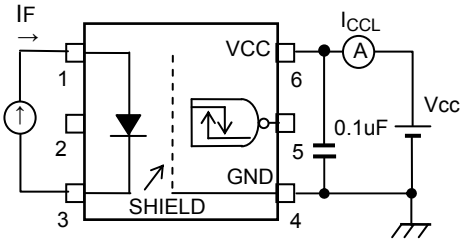


TEST CIRCUIT 2 : V_{OH}

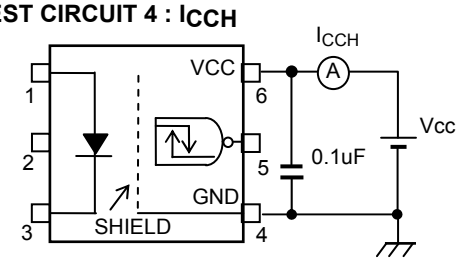


$V_{OH}=V_{CC}-V_O$ [V]

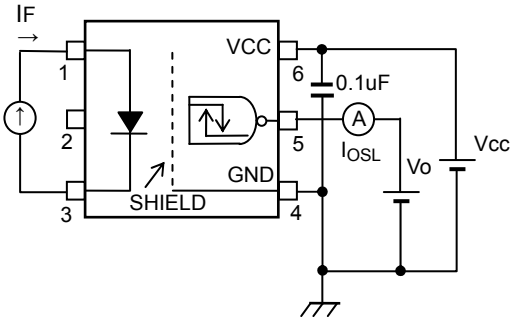
TEST CIRCUIT 3 : I_{CCL}



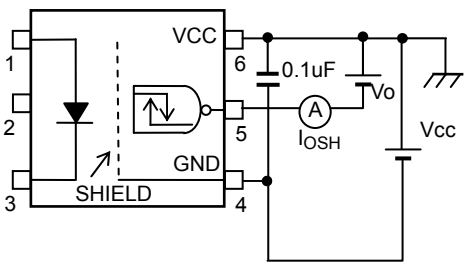
TEST CIRCUIT 4 : I_{CCH}



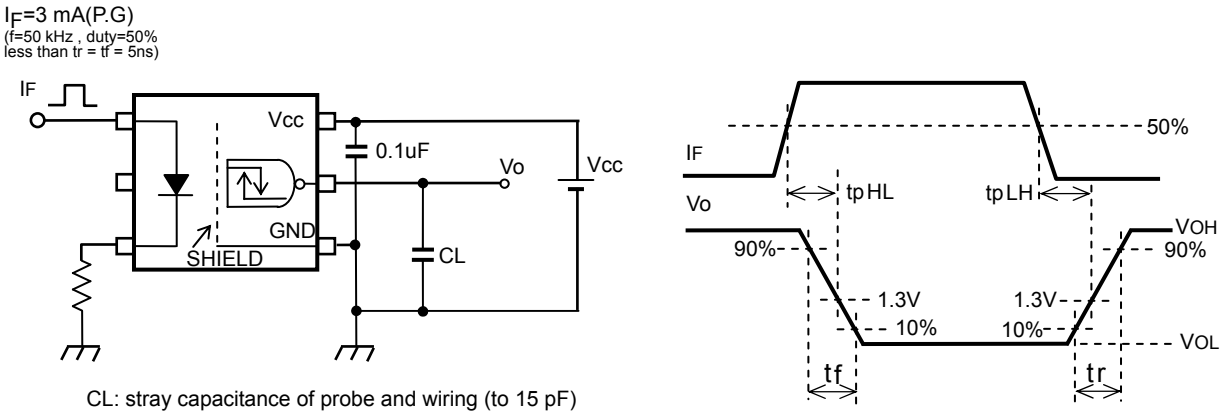
TEST CIRCUIT 5 : I_{OSL}



TEST CIRCUIT 6 : I_{OSH}

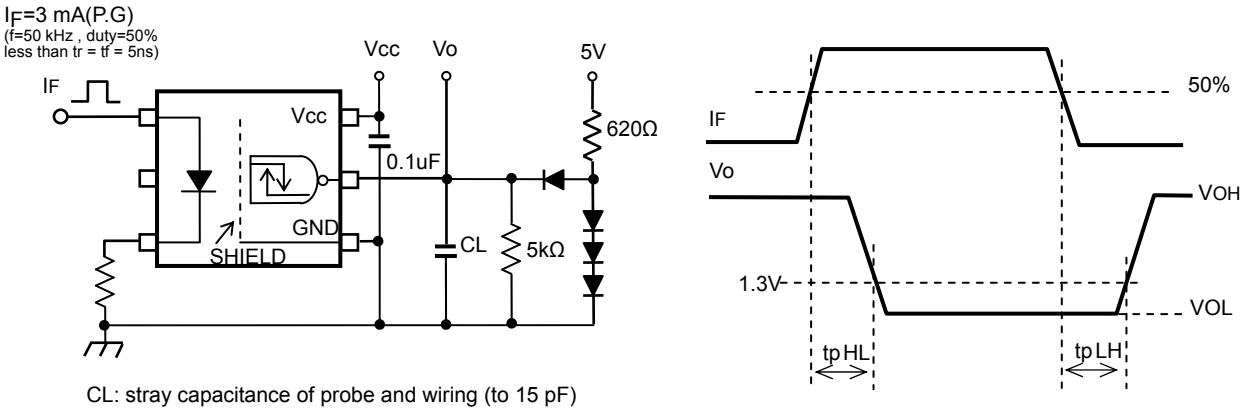


TEST CIRCUIT 7: Switching Time Test Circuit



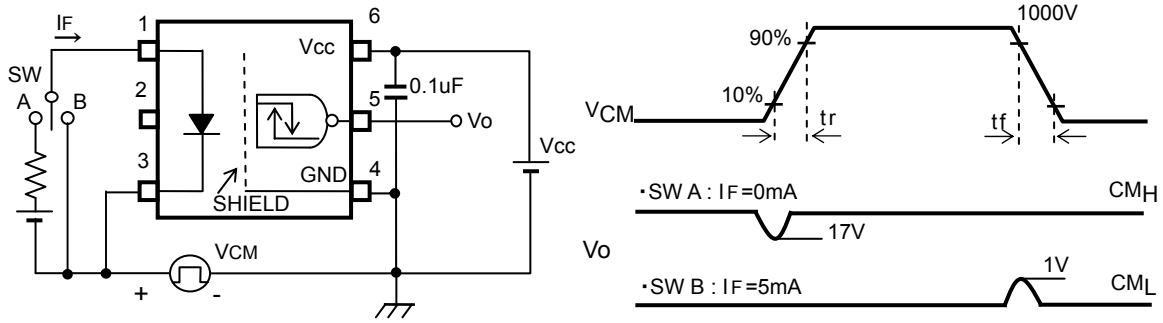
CL: stray capacitance of probe and wiring (to 15 pF)

TEST CIRCUIT 8: Switching Time Test Circuit



CL: stray capacitance of probe and wiring (to 15 pF)

TEST CIRCUIT 9: Common-Mode Transient Immunity Test Circuit



$$CM_H = \frac{800(V)}{t_r(\mu s)} \qquad CM_L = -\frac{800(V)}{t_f(\mu s)}$$

CM_H (CM_L) is the maximum rate of rise (fall) of the common mode voltage that can be sustained with the output voltage in the high (low) state.

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